

Notice of References Cited		Application/Control No. 10/595,439	Applicant(s)/Patent Under Reexamination WOON ET AL.	
		Examiner CATHERINE THIAW	Art Unit 2493	Page 1 of 1

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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